

Exploiting Small Leakages in Masks to Turn a Second-Order Attack into a First-Order Attack

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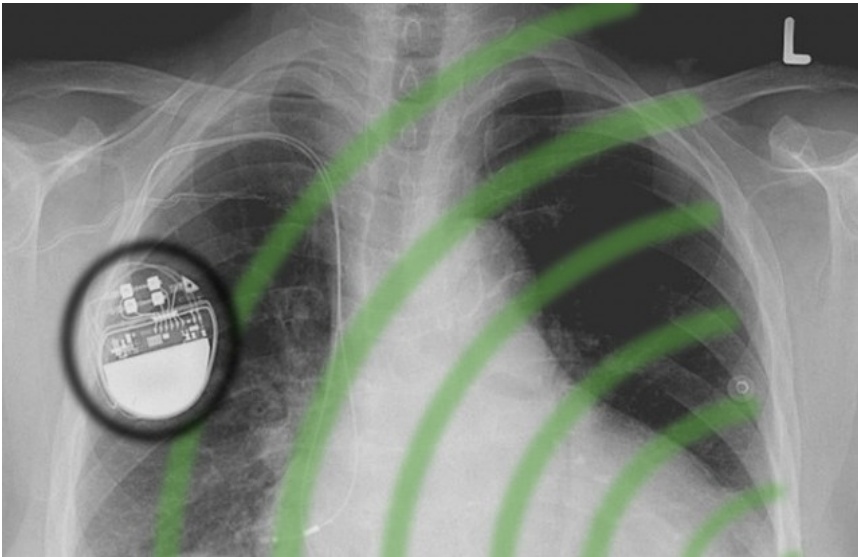


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Motivation

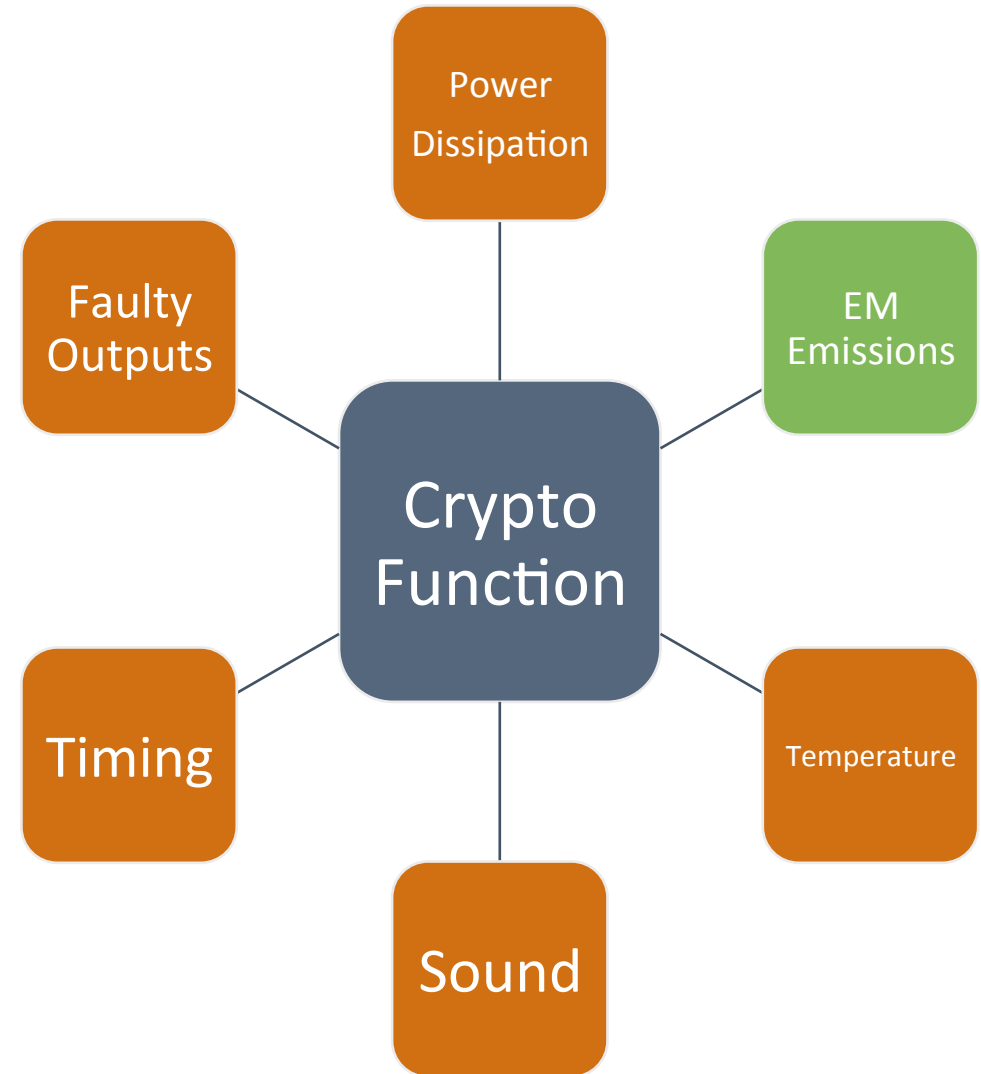
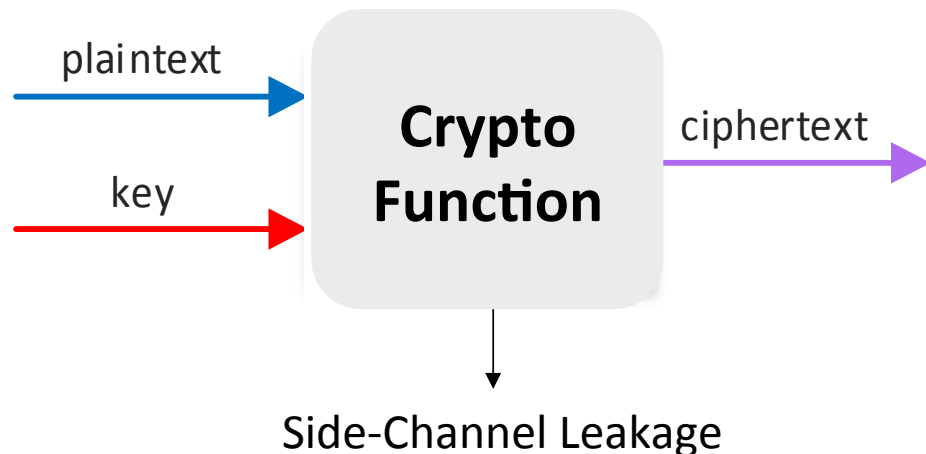


BitLocker Drive Encryption



Side-Channel Attacks

- Algorithm implementations may inadvertently leak information through different sources
- These sources are called “side-channels”
- A side-channel attack exploits one or more of these to learn secret information



Masking Countermeasure

- Countermeasures such as masking have been developed to thwart side-channel attacks
- Masking tries to remove the correlation between the power consumption and the data that is being handled

Boolean Masking

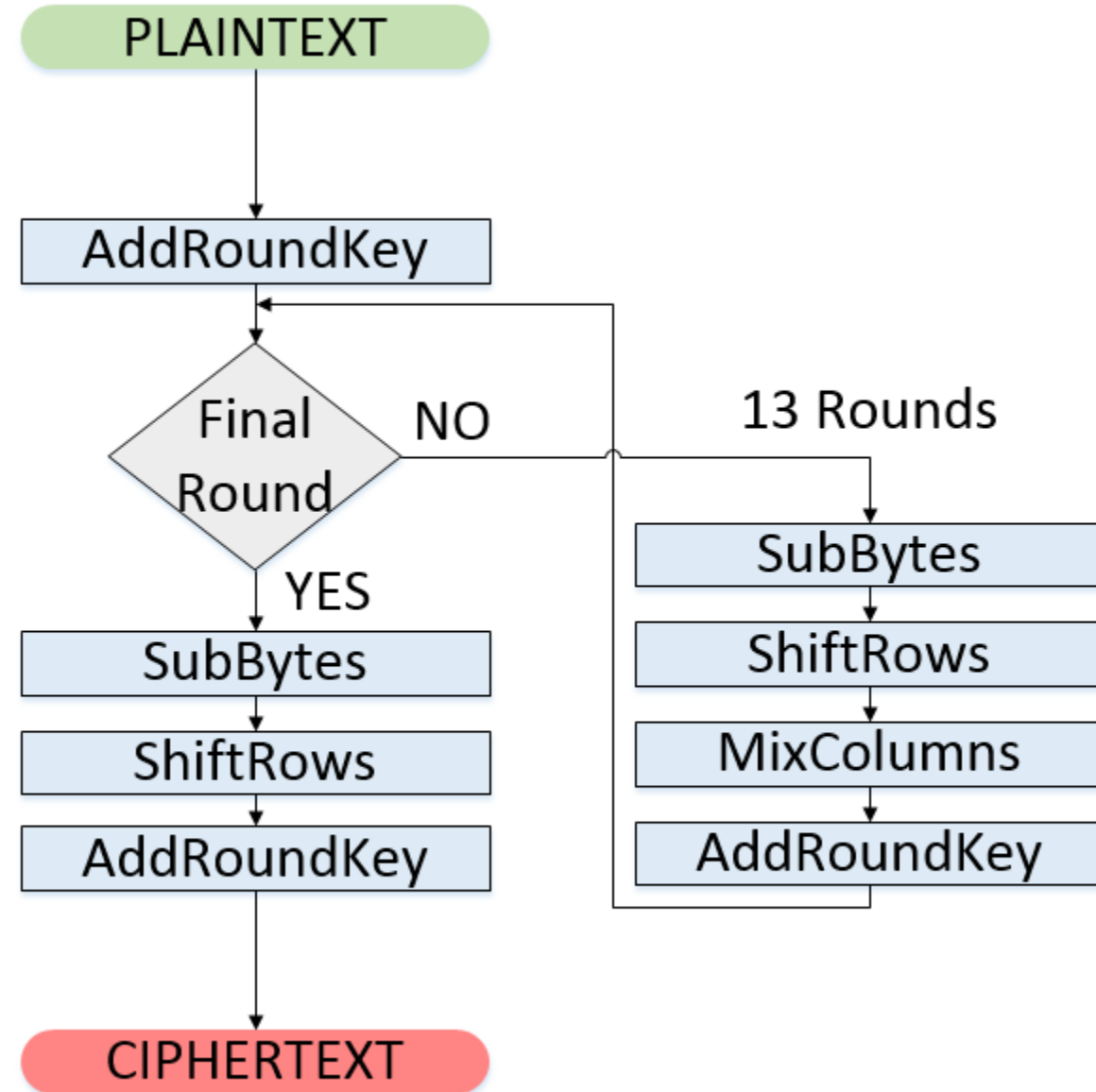


d : plaintext, k : secret key, m : uniformly distributed random mask

Advanced Encryption Standard (AES)

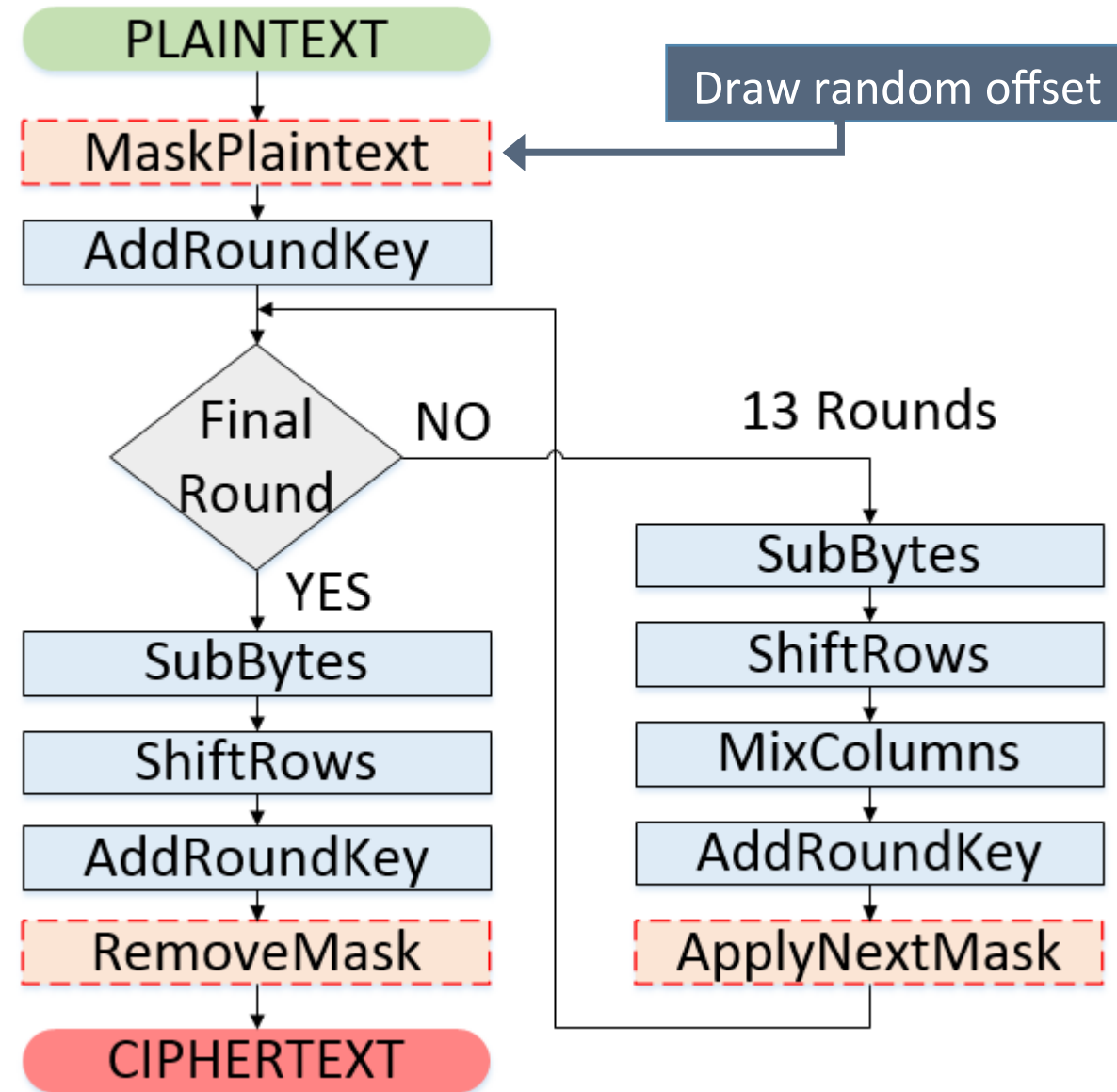
- Plaintext/ciphertext: 128 bits
- Key: 128/192/**256** bits
- 13 rounds + 1 pre-round

AddRoundKey	XOR operation
SubBytes	Look-up table
ShiftRows	Byte-wise permutation
MixColumns	Matrix multiplication



Rotating S-Box Masking (RSM)

- Carefully chosen masks reduces storage requirements
 - RSM uses 16 masks
- HW : 2nd-order zero-offset resistance
- EM traces publicly from DPA Contest v4
 - AES256-RSM implemented on a smartcard with 8-bit microcontroller Atmel ATmega-163



Mask Recovery Attack

- A 1st order CPA attack fails to recover the key after 100,000 traces
- Prior work: non-uniform distribution of the masks after an XOR (174), collision attacks (1100), 2nd-order CPA (300),
- Our attack : 10 traces

Observation

- Masks are deployed in a predictable sequence
- The device leaks the Hamming Weight of the masks each time they are handled

Idea

- Launch a 1st order *horizontal* CPA attack to recover the masks
- Recover the masks, then recover the key

Moradi, A., Guilley, S., Heuser, A., “Detecting Hidden Leakages”, ACNS’14

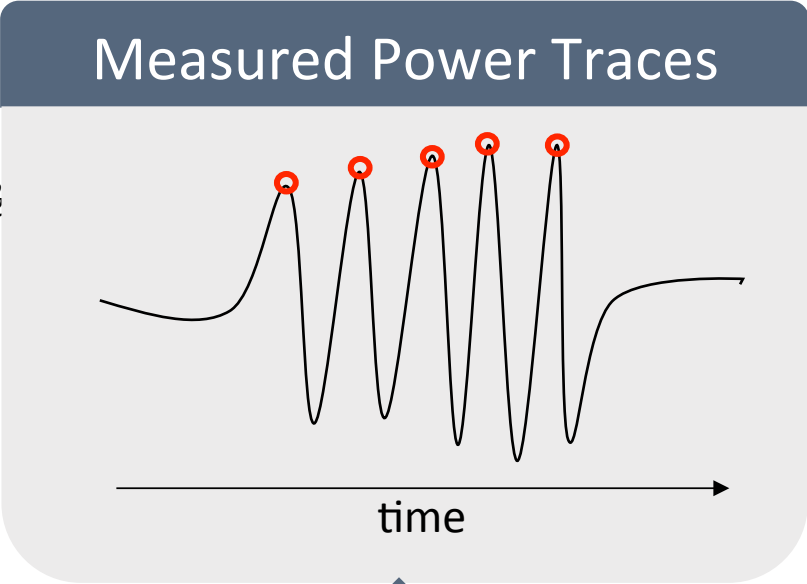
Kutzner, S., Poschmann, A., “On the Security of RSM — Presenting 5 First and Second-order Attacks”, COSADE’14

Belgarric, P., Bhasin, S., Bruneau, N., Danger, J.L., Debande, N., Guilley, S., Heuser, A., Najm, Z., Rioul, O., “Time-Frequency Analysis for Second-Order Attacks”, CARDIS’14

1st order CPA Attack

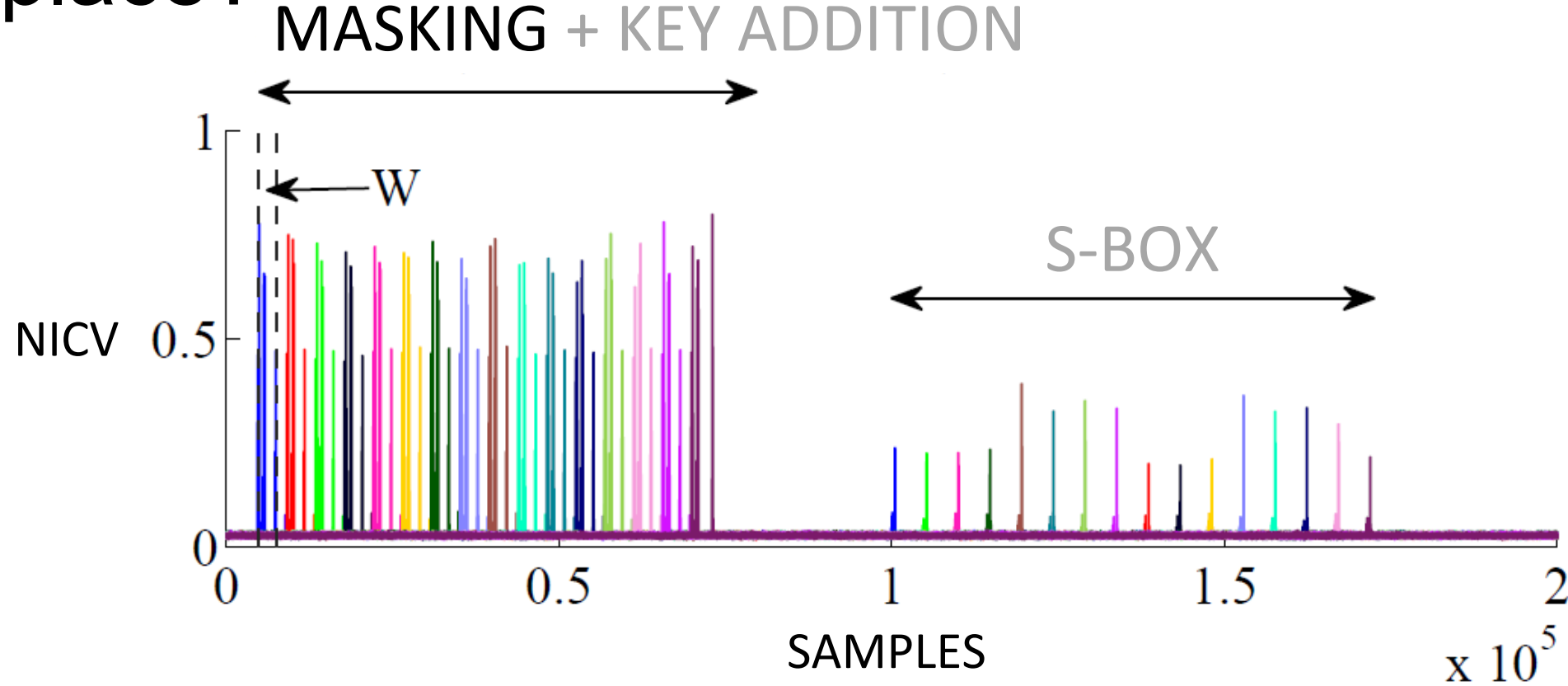
Hypothetical Power Model

$HW(\blacksquare\blacksquare[\blacksquare\blacksquare\blacksquare m_0 m_1 : \&\blacksquare m_1 m_2 : \&\blacksquare\blacksquare m_2 m_3 : \&\blacksquare\blacksquare \dots : \&$



Correlation

Mask Recovery – When does masking take place?



$$NICV = \text{Var}(\mathbb{E}[T|X]) / \text{Var}(T)$$

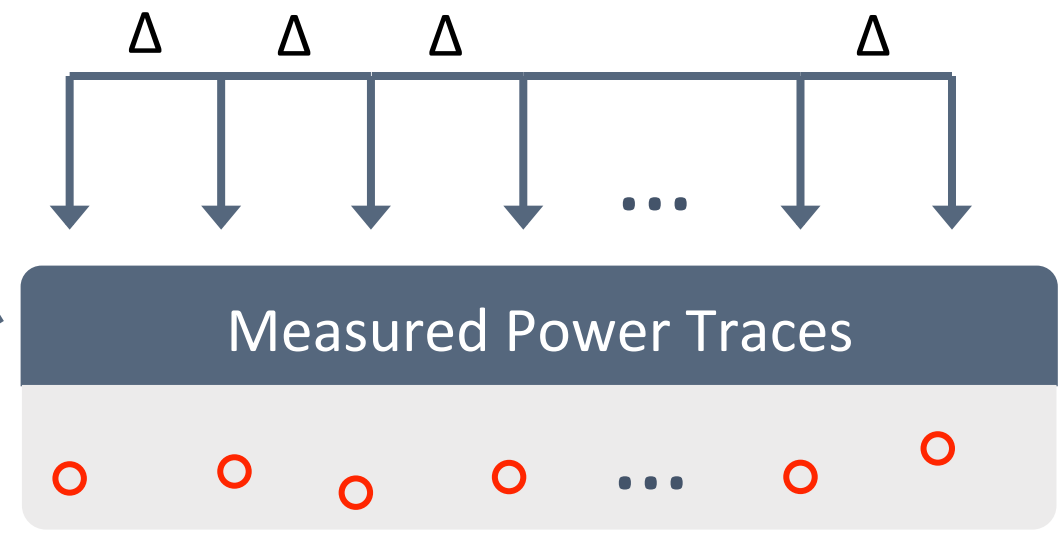
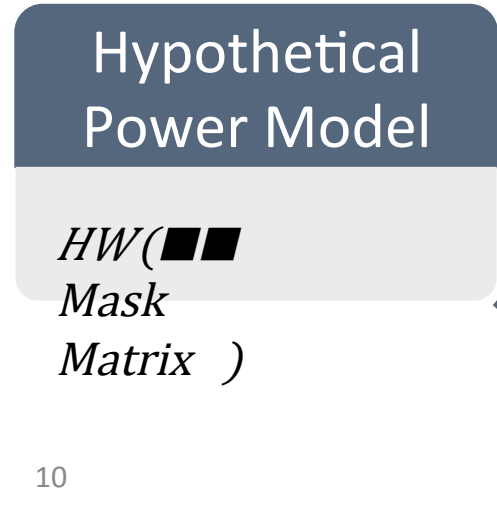
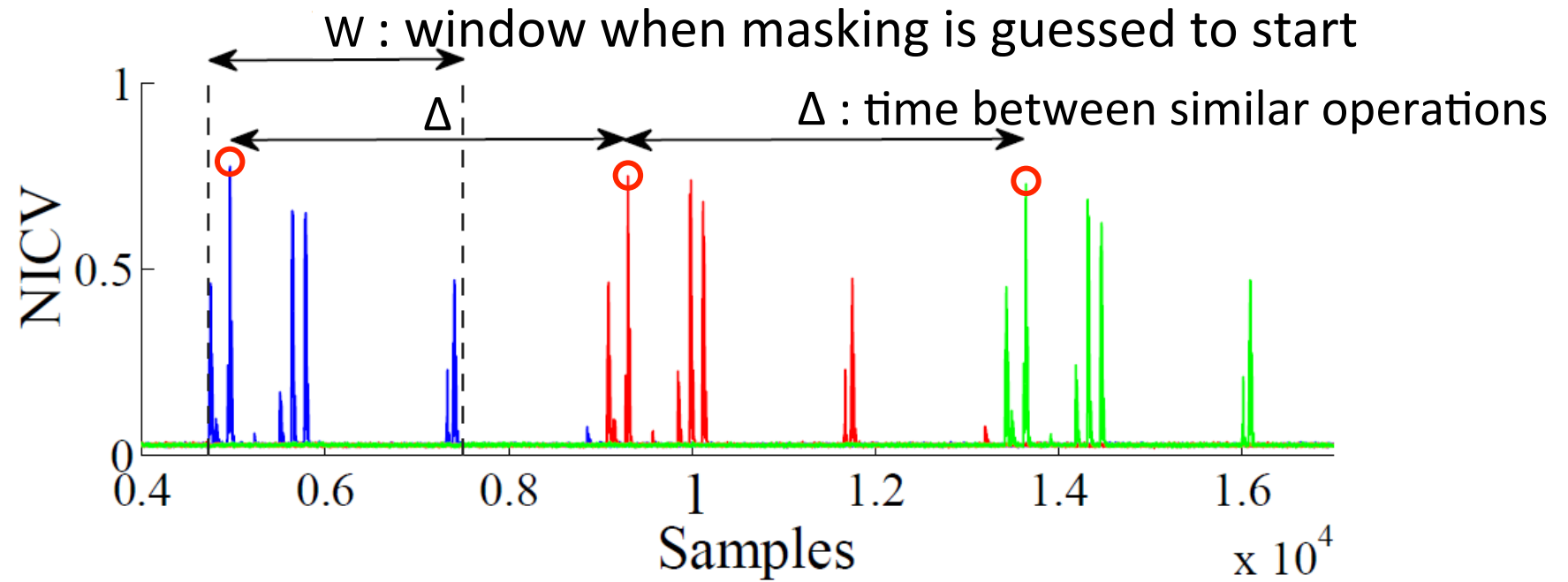
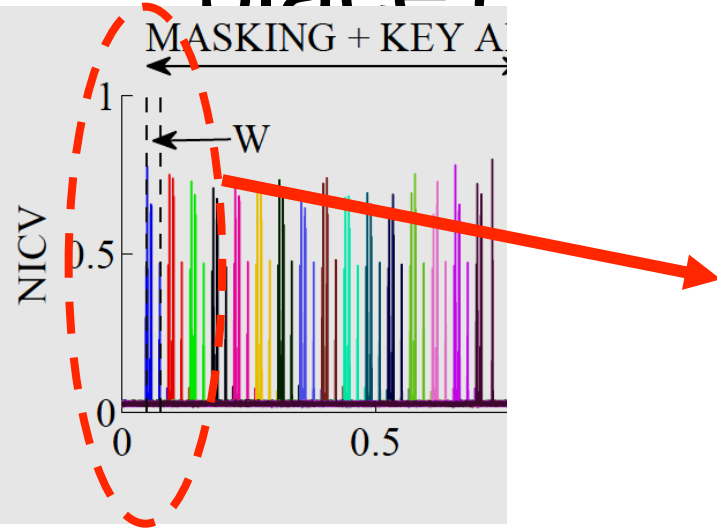
W : window when masking is suspected to occur

NICV : Normalized Inter-class Variance

T : power traces

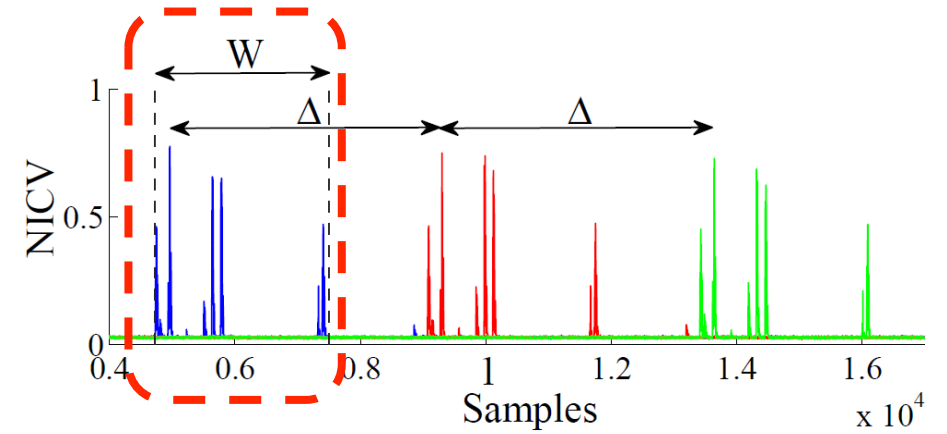
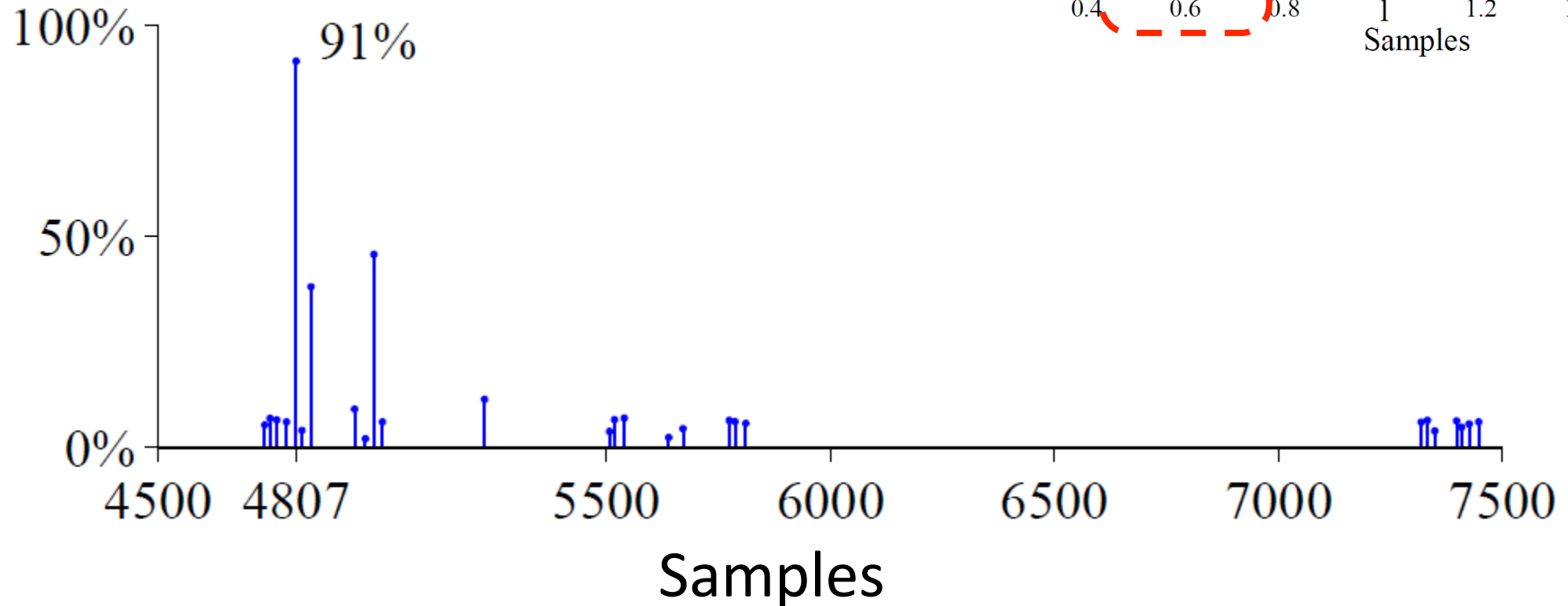
X : plaintext byte

Mask Recovery – When does masking take place?



Mask Recovery Results

Mask Recovery Success Rate

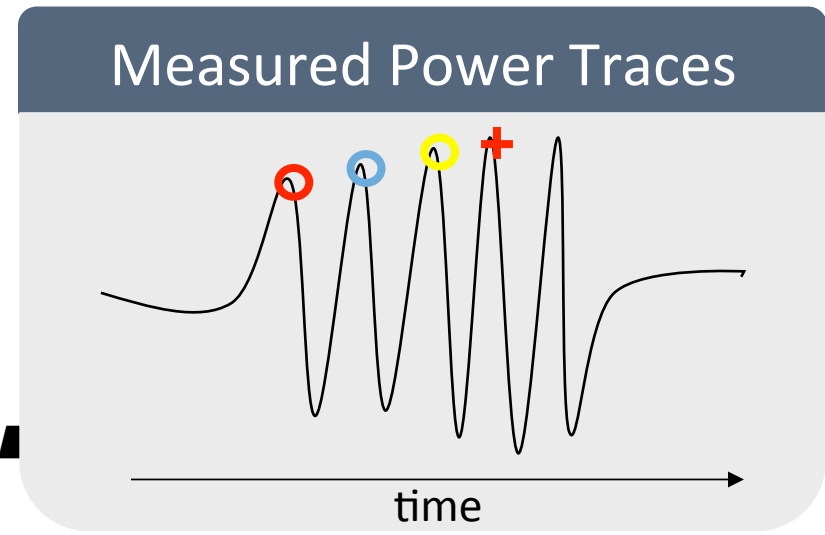


Taken over 10,000 power traces

2nd-order CPA Attack

Hypothetical Power Model

$HW(\mathbf{m} \oplus \mathbf{m} \oplus m_0 \oplus m_1 : \& \mathbf{m} \oplus m_1 \oplus m_2 : \& \mathbf{m} \oplus m_2 \oplus m_3 : \& \mathbf{m} \oplus \dots : \& \mathbf{m} \oplus m_{15} \oplus m_0 \oplus \dots)$

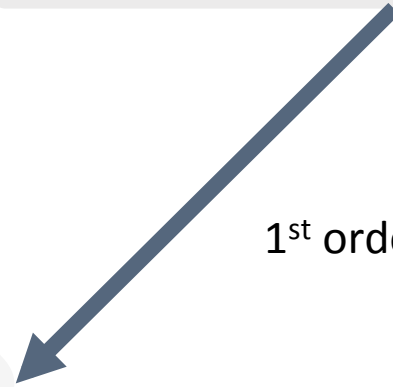
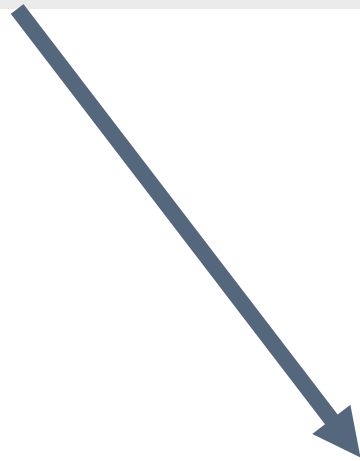


Apply combination function

Pre-processed Traces

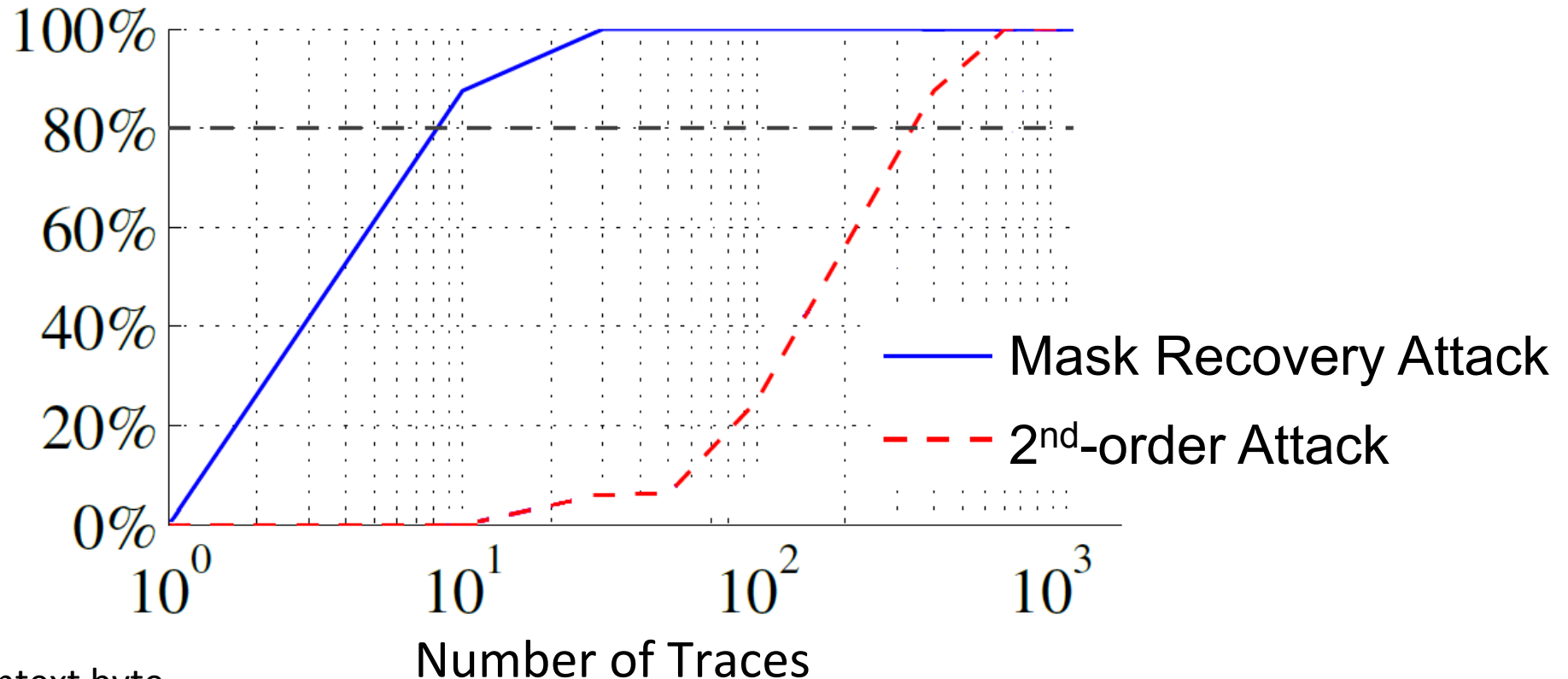
1st order CPA

Correlation



Comparison with 2nd-Order Attack[^]

Key Bytes Recovered : SNR = 2.689



T : power traces, X : plaintext byte

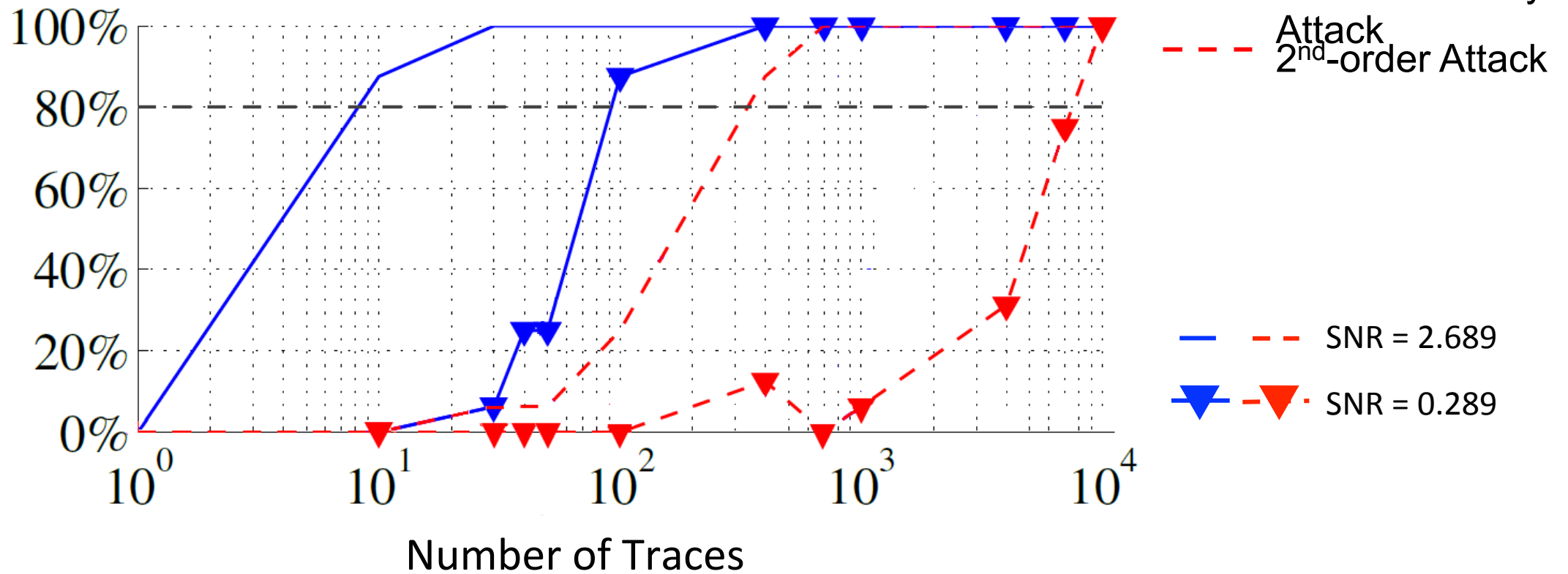
$$*SNR = \frac{1}{1/NICV - 1} = \frac{Var(\mathbb{E}[T|X])}{Var(T)} - \frac{Var(\mathbb{E}[T|X])}{Var(T)}$$

*S. Bhasin, J-L Danger, S. Guilley, and Z. Najm, "Side-Channel Leakage and Trace Compression using Normalized Inter-Class Variance", HASP'14

[^]E. Prouff, M. Rivain, and R. Bevan. Statistical analysis of second order differential power analysis. IEEE Trans. on Computers'09

Adding Noise to the Power Traces

Key Bytes Recovered



* $SNR = \frac{1}{1/NICV - 1} = \frac{Var(\mathbb{E}[T|X])}{Var(T)} - \frac{Var(\mathbb{E}[T|X])}{Var(\mathbb{E}[T|X])}$

T : power traces, X : plaintext byte

*S. Bhasin, J-L Danger, S. Guilley, and Z. Najm, "Side-Channel Leakage and Trace Compression using Normalized Inter-Class Variance", HASP'14

Conclusion

- Our attack outperforms a 2nd-order attack by two orders of magnitude w.r.t to number of traces needed to recover the key
- A 2nd-order attack fails to recover the key for $\text{SNR} < 0.289$, while our attack succeeds for $\text{SNR} \leq 0.035$
- The implementation leaks the Hamming Weight of the masks as they are fetched from memory
- The predictable deployment order of the masks and Hamming Weight variation allow an attacker to recover the mask offset
- We also analyzed the relationship between mask recovery success rate and window width/number of masks attacked

Thank you!

Questions?